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# Specification for Approval

Customer:	
Model Name:	

Supplier Approval			Customer approval
R&D Designed	R&D Approved	QC Approved	
Peter	Peng Jun		



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## **Revision Record**

REV NO.	REV DATE	CONTENTS	Note
Α	2019-10-14	NEW ISSUE	

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### 1. Scope

This specification defines general provisions as well as inspection standards for TFT module supplied by AMSON electronics.

If the event of unforeseen problem or unspecified items may occur, naturally shall negotiate and agree to solution

### 2. General Information

#### LCM

ITEM	STANDARD VALUES	UNITS
LCD type	2.8"TFT	
Dot arrangement	240(RGB)×320	dots
Color filter array	RGB vertical stripe	
Display mode	Transmission / Normally Black	-
Gray Scale Inversion Direction	80/80/80	
Eyes Viewing Direction	ALL	
Driver IC	ST7789V	
Module size	50.0(W)×69.2(H)×4.0(T)	mm
Active area	43.2(W)×57.6(H)	mm
Dot pitch	0.18(W)×0.18(H)	mm
Interface	i80-system 8/16/18-bitMCU interface 3SPI/4SPI/ 16/18-bitRGB interface	
Operating temperature	-20~ +70	°C
Storage temperature	-30~ +80	°C
Back Light	4 White LED	

### **CTP**

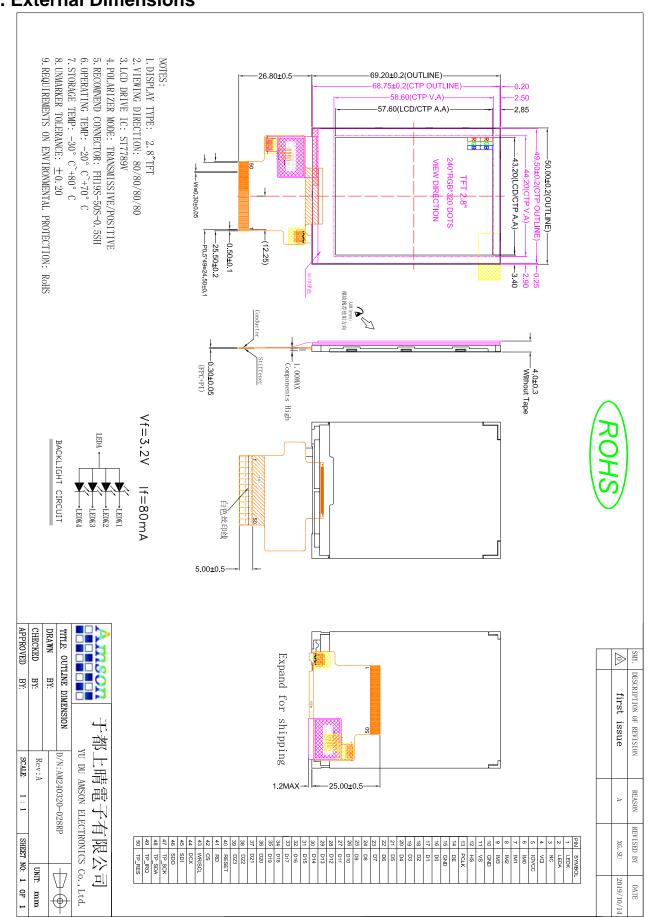
ITEM	STANDARD VALUES	UNITS
CTP type	Cover Lens + sensor + FPC	
CTP Driver IC	FT6336G	
Surface Treatment	6H	
Transmittance	≥86%	
The cover hardness	6H	
CTP size	49.50(W)×68.75(H)×1.55(T)	mm
CTP Active area	44.2(W)×58.60(H)	mm
CTP Interface	I2C	
response time	10	ms



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### 3. External Dimensions





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### 4. Interface Description

PIN NO.	PIN NAME	DESCRIPTION
1	LEDK	The cathode of LED power
2	LEDA	The Anode of LED power
3	NC	NC
4	VCI	Analog operating voltage.
5	IOVCC	Logic operating voltage.
6~9	IM0~IM3	MPU interface mode select pin,(FYI NOTE1)
10	GND	Power ground
11	VSYNC	Frame synchronizing signal for RGB interface operation.
12	HSYNC	Line synchronizing signal for RGB interface operation.
13	DOTCLK	Dot clock signal for RGB interface operation.
14	DE	Data enable signal for RGB interface operation.
15	GND	Power ground
16-33	DB0-DB17	Data bus
34`39	DB18~DB23	NC
40	RESET	Reset pin setting either pin low initializes the LSI Must be reset after power supplied
41	RD	Read signal input terminal, Active at 'L'.
42	CS	Chip select signal input terminal, Active at 'L'
43	/WR	Write enable in MCU parallel interface Display data/command selection pin in 4-line serial interface Second Data lane in 2 data lane serial interfaceIf not used, please fix this pin at VDDI or DGND.
44	DCX /SCL	Display data/command selection pin in parallel interface. This pin is used to be serial interface clock DCX='1': display data or parameter DCX='0': command data.
45	SDI	When IM [3]: Low, Serial in/out signal. When IM [3]: High, Serial input signal. The data is applied on the rising edge of the SCL signal.
46	SDO	Serial output signal. The data is applied on the rising edge of the SCL signal.
47	TP_SCK	CTP I2C_clock.



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48	TP_SDA	CTP I2C_data.
49	TP_IRQ	CTP interruption signal.
50	TP_RES	CTP reset pin. Active low to enter reset state.

#### Note1:

-The MCU interface mode select.

IM3	IM2	IM1	IM0	MPU Interface Mode	Data pin
0	0	0	0	80-8bit parallel I/F	DB[7:0]
0	0	0	1	80-16bit parallel I/F	DB[15:0]
0	0	1	0	80-9bit parallel I/F	DB[8:0]
0	0	1	1	80-18bit parallel I/F	DB[17:0],
0	1	)	1	3-line 9bit serial I/F	SDA: in/out
0	1	0	1	O data lana sarial I/E	SDA: in/out
				2 data lane serial I/F	WRX: in
0	1	1	0	4-line 8bit serial I/F	SDA: in/out
1	0	0	0	90-16bit parallal I/E II	DB[17:10],
-	0	0	0	80-16bit parallel l/F Ⅱ	DB[8:1]
1	0	0	1	80-8bit parallel I/F Ⅱ	DB[17:10]
1	0	1	0	80-18bit parallel I/F Ⅱ	DB[17:0],
1	0	1	1	80-9bit parallel I/F Ⅱ	DB[17:9]
1	1	0	1	3-line 9bit serial I/F Ⅱ	SDA: in/
'		U		5-line spit serial I/F II	SDO: out
1	1	1		4-line 8bit serial I/F ∏	SDA:in/
' '	<u> </u>		0	4-IIIIe obit serial I/F II	SDO: out

If not used, please fix this pin at VDDI or DGND.



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5. Absolute Maximum Ratings

Item	Symbol	Min.	Max.	Unit
Logic Supply Voltage	IOVCC	-0.3	4.6	٧
Analog Supply Voltage	VCI	-0.3	4.6	V
Input Voltage	Vin	-0.3	IOVCC +0.3	٧
Operating Temperature	Тор	-20	70	°C
Storage Temperature	Тѕт	-30	80	°C
Storage Humidity	HD	20	90	%RH

### 6. DC Characteristics

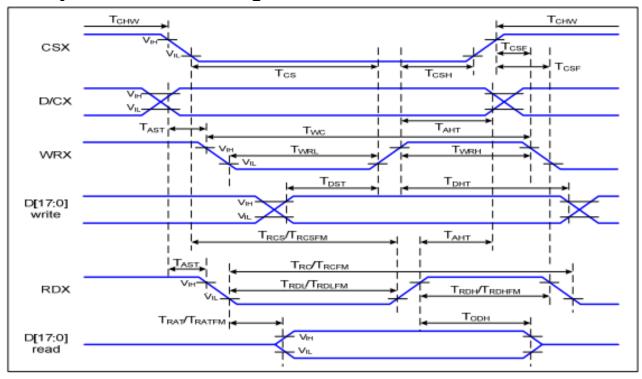
Item	Symbol	Min.	Тур.	Max.	Unit	Remark
Logic Supply Voltage	IOVCC	1.65	2.8	3.3	V	-
Analog Supply Voltage	VCI	2.5	2.8	3.3	V	-
Input High Voltage	V <sub>IH</sub>	0.7VCI	-	VCI	V	-
Input Low Voltage	V <sub>IL</sub>	GND	-	0.3 VCI	V	-
Output High Voltage	V <sub>OH</sub>	0.8 VCI	-	VCI	V	-
Output Low Voltage	V <sub>OL</sub>	GND	-	0.2 VCI	V	-
I/O Leak Current	llı	-1	-	1	uA	-
Supply Current	IDD	-	7.0	10	mA	-

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### 7. Timing Characteristics

### 7.1 i80-System Interface Timing Characteristics



Signal	Symbol	Parameter	Min	Max	Unit	Description
D/CX	T <sub>AST</sub>	Address setup time	0		ns	
DICX	T <sub>AHT</sub>	Address hold time (Write/Read)	10		ns	•
	T <sub>CHW</sub>	Chip select "H" pulse width	0		ns	
	T <sub>CS</sub>	Chip select setup time (Write)	15		ns	
CSX	T <sub>RCS</sub>	Chip select setup time (Read ID)	45		ns	
CSA	T <sub>RCSFM</sub>	Chip select setup time (Read FM)	355		ns	-
	T <sub>CSF</sub>	Chip select wait time (Write/Read)	10		ns	
	T <sub>CSH</sub>	Chip select hold time	10		ns	
	T <sub>WC</sub>	Write cycle	66		ns	
WRX	T <sub>WRH</sub>	Control pulse "H" duration	15		ns	
	$T_{WRL}$	Control pulse "L" duration	15		ns	
	T <sub>RC</sub>	Read cycle (ID)	160		ns	
RDX (ID)	$T_RDH$	Control pulse "H" duration (ID)	90		ns	When read ID data
	$T_{RDL}$	Control pulse "L" duration (ID)	45		ns	
BDV	T <sub>RCFM</sub>	Read cycle (FM)	450		ns	When read from
RDX (FM)	T <sub>RDHFM</sub>	Control pulse "H" duration (FM)	90		ns	frame memory
	$T_{RDLFM}$	Control pulse "L" duration (FM)	355		ns	name memory
D[17:0]	T <sub>DST</sub>	Data setup time	10		ns	For CL=30pF

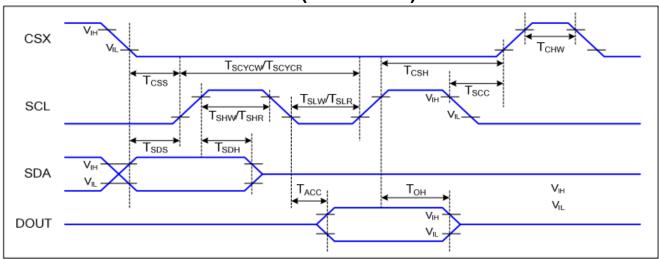


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T <sub>DHT</sub>	Data hold time			ns				
T <sub>RAT</sub>	Read access time (ID)		40	ns				
T <sub>RATFM</sub>	Read access time (FM)		340	ns				
T <sub>ODH</sub>	Output disable time	20	80	ns				

### 7.2 Serial Interface Characteristics (3-line serial):



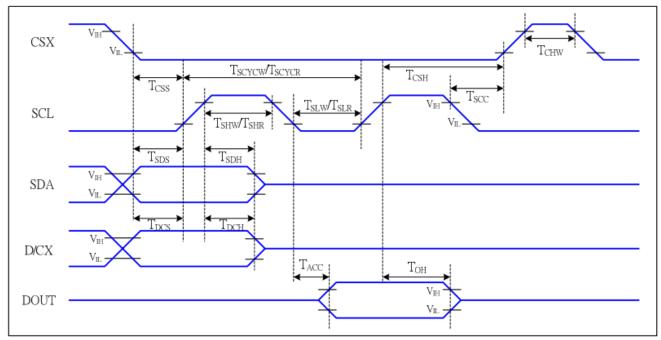
VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=-30 to 70  $^{\circ}\mathrm{C}$ 

Signal	Symbol	Parameter	Min	Max	Unit	Description
	T <sub>CSS</sub>	Chip select setup time (write)	15		ns	
	T <sub>CSH</sub>	Chip select hold time (write)	15		ns	
CSX	T <sub>CSS</sub>	Chip select setup time (read)	60		ns	
	T <sub>scc</sub>	Chip select hold time (read)	65		ns	
	T <sub>CHW</sub>	Chip select "H" pulse width	40		ns	
	T <sub>SCYCW</sub>	Serial clock cycle (Write)	66		ns	
	$T_{SHW}$	SCL "H" pulse width (Write)	15		ns	
SCL	T <sub>SLW</sub>	SCL "L" pulse width (Write)	15		ns	
SCL	T <sub>SCYCR</sub>	Serial clock cycle (Read)	150		ns	
	T <sub>SHR</sub>	SCL "H" pulse width (Read)	60		ns	
	$T_{SLR}$	SCL "L" pulse width (Read)	60		ns	
SDA	T <sub>SDS</sub>	Data setup time	10		ns	
(DIN)	T <sub>SDH</sub>	Data hold time	10		ns	
DOUT	T <sub>ACC</sub>	Access time	10	50	ns	For maximum CL=30pF
ווויטע	Тон	Output disable time	15	50	ns	For minimum CL=8pF

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### 7.3 Serial Interface Characteristics (4-line serial):

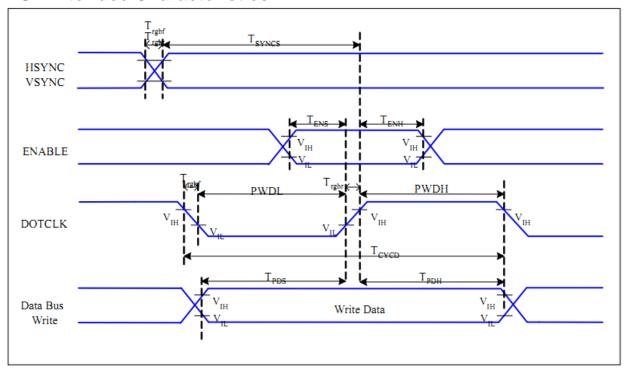


Signal	Symbol	Parameter	MIN	MAX	Unit	Description
	T <sub>CSS</sub> Chip select setup time (write)		15		ns	
	T <sub>CSH</sub>	Chip select hold time (write)	15		ns	
CSX	T <sub>CSS</sub>	Chip select setup time (read)	60		ns	
	T <sub>SCC</sub>	Chip select hold time (read)	65		ns	
	T <sub>CHW</sub>	Chip select "H" pulse width	40		ns	
	T <sub>SCYCW</sub>	Serial clock cycle (Write)	66		ns	-write command & data
	T <sub>SHW</sub>	SCL "H" pulse width (Write)	15		ns	ram
SCL	T <sub>SLW</sub>	SCL "L" pulse width (Write)	15		ns	Idili
SCL	T <sub>SCYCR</sub>	Serial clock cycle (Read)	150		ns	read command 0 data
	T <sub>SHR</sub>	SCL "H" pulse width (Read)	60		ns	-read command & data ram
	T <sub>SLR</sub>	SCL "L" pulse width (Read)	60		ns	Idili
D/CX	T <sub>DCS</sub>	D/CX setup time	10		ns	
DICX	T <sub>DCH</sub>	D/CX hold time	10		ns	
SDA	T <sub>SDS</sub>	Data setup time	10		ns	
(DIN)	T <sub>SDH</sub>	Data hold time	10		ns	
DOUT	T <sub>ACC</sub> Access time		10	50	ns	For maximum CL=30pF
Тон		Output disable time	15	50	ns	For minimum CL=8pF

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### 7.4 RGB Interface Characteristics:



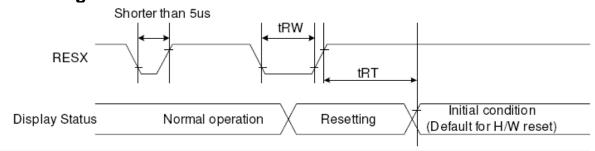
Signal	Symbol	Parameter		MAX	Unit	Description
HSYNC, VSYNC	T <sub>SYNCS</sub>	VSYNC, HSYNC Setup Time		•	ns	
ENABLE	T <sub>ENS</sub>	Enable Setup Time	25	-	ns	
ENABLE	T <sub>ENH</sub>	Enable Hold Time	25	-	ns	
	PWDH	DOTCLK High-level Pulse Width	60	-	ns	
DOTCLK	PWDL	DOTCLK Low-level Pulse Width	60	-	ns	
DOTCLK	T <sub>CYCD</sub>	DOTCLK Cycle Time	120	-	ns	
	Trghr, Trghf	DOTCLK Rise/Fall time	-	20	ns	
DB	T <sub>PDS</sub>	PD Data Setup Time	50	-	ns	
DB	$T_PDH$	PD Data Hold Time	50	-	ns	

Table 7 18/16 Bits RGB Interface Timing Characteristics

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### 7.5 Reset Timing Characteristics



Signal	Symbol	Parameter	Min	Max	Unit
RESX	tRW	Reset pulse duration	10		uS
	tRT	Reset cancel		5 (note 1,5)	mS
	tri	neset cancel		120 (note 1,6,7)	mS

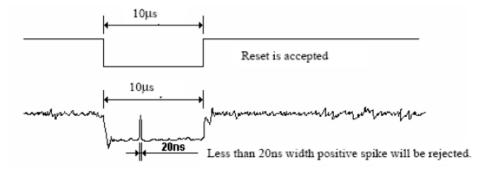
Note 1: The reset cancel includes also required time for loading ID bytes, VCOM setting and other settings from NV memory to registers. This loading is done every time when there is HW reset cancel time (tRT) within 5 ms after a rising edge of RESX.

Note 2: Spike due to an electrostatic discharge on RESX line does not cause irregular system reset according to the table below: -

RESX Pulse	Action
Shorter than 5us	Reset Rejected
Longer than 10us	Reset
Between 5us and 10us	Reset starts

Note 3: During the Resetting period, the display will be blanked (The display is entering blanking sequence, which maximum time is 120 ms, when Reset Starts in Sleep Out –mode. The display remains the blank state in Sleep In -mode.) And then return to Default condition for Hardware Reset.

Note 4: Spike Rejection also applies during a valid reset pulse as shown below:



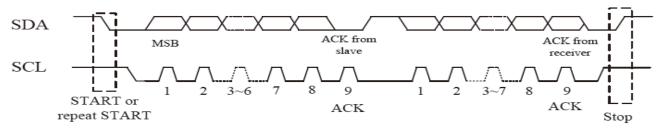
- Note 5: When Reset applied during Sleep In Mode.
- Note 6: When Reset applied during Sleep Out Mode.
- Note 7: It is necessary to wait 5msec after releasing RESX before sending commands. Also Sleep Out command cannot be sent for 120msec.

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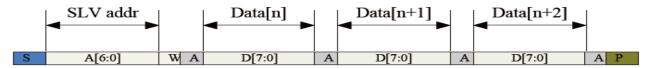
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### 7.6 CTP Timing characteristics

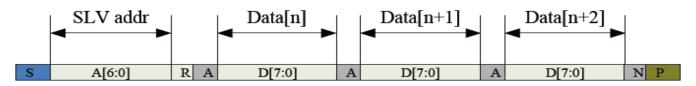
### 7.6.1 Serial Interface (I<sup>2</sup>C)



12C Serial Data Transfer Format



I2C master write, slave read



12C master read, slave write

Table 2-1 lists the meanings of the mnemonics used in the above figures.

#### Mnemonics Description

Mnemonics	Description
S	I2C Start or I2C Restart
A[6:0]	Slave address
R/W	READ/WRITE bit, '1' for read, '0' for write
A(N)	ACK(NACK)
P	STOP: the indication of the end of a packet (if this bit is missing, S will indicate the end of the current packet and the beginning of the next packet)

I2C Interface Timing Characteristics is shown in Table 2-2.

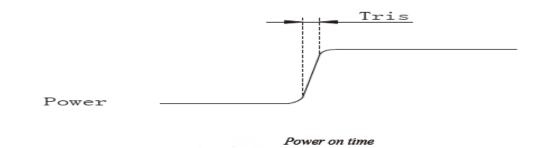
#### I2C Timing Characteristics

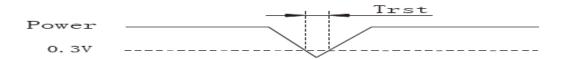
Parameter	Min	Max	Unit
SCL frequency	10	400	KHz
Bus free time between a STOP and START condition	4.7	\	us
Hold time (repeated) START condition	4.0	\	us
Data setup time	250	\	ns
Setup time for a repeated START condition	4.7	\	us
Setup Time for STOP condition	4.0	\	us

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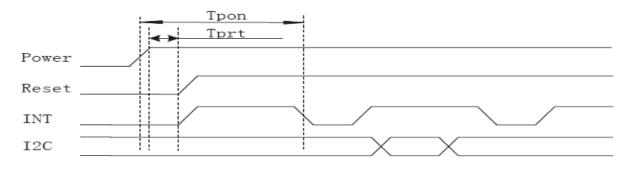
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### 7.6.2 POWER NO /Reset/Wake Sequence



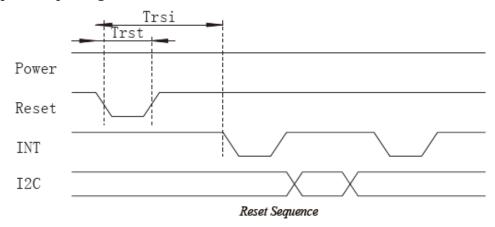


Power Cycle requirement



Power on Sequence

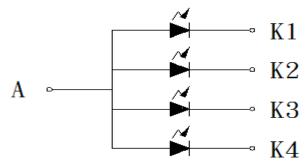
Reset time must be enough to guarantee reliable reset, the time of starting to report point after resetting approach to the time of starting to report point after powering on.



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### 8. Backlight Characteristic



Item	Symbol	MIN	TYP	MAX	UNIT	TestCondition
Supply Voltage	Vf	2.9	3.2	3.5	V	If=80mA
Supply Current	If	-	80		mA	-
Luminous Intensity for LCM	-	200	230	-	cd/m <sup>2</sup>	If=80mA
Uniformity for LCM	-	75	80	-	%	If=80mA
Life Time	-	50000	-	-	Hr	If=80mA
Backlight Color	White					



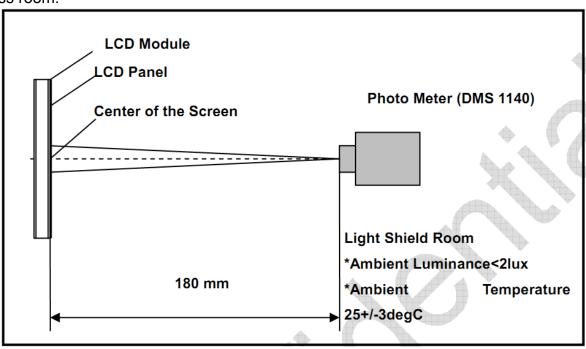
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9. Optical Characteristics

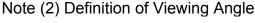
Item	Conditions	S	Min.	Тур.	Max.	Unit	Note	
	Horizontal	θL	-	80	-			
Viewing Angle	попиона	θR	-	80	-	dograo	(1) (2) (6)	
(CR>10)	Vertical	θт	-	80	-	degree	(1),(2),(6)	
	vertical	θв	-	80	-			
Contrast Ratio	Center		600	800	-	-	(1),(3),(6)	
Response Time	Rising + Falling		-	16	-	ms	(1),(4),(6)	
	Red x			TBD		-		
	Red y Green x			TBD		-		
				TBD				
CF Color	Green y		]	TBD		-	(1) (6)	
Chromaticity (CIE1931)	Blue x		Typ.	TBD	Typ.		(1), (6)	
,	Blue y		-0.05	TBD	+0.05	-		
	White x White y			TBD		-		
			White y		TBD		-	
NTSC	CIE1931		-	60	-	%	(1),(6)	

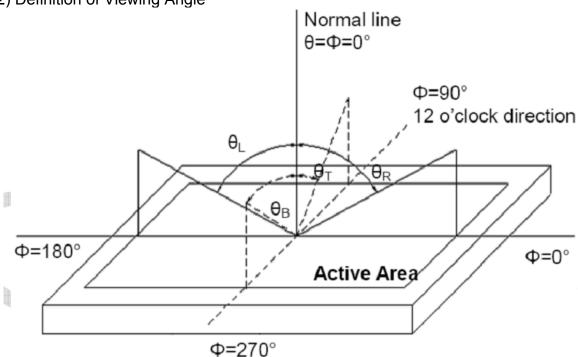
Note (1) Measurement Setup: The LCD module should be stabilized at given temp. 25°C for 15 minutes to avoid abrupt temperature change during measuring. In order to stabilize the luminance, the measurement should be executed after lighting backlight for 15 minutes in a windless room.



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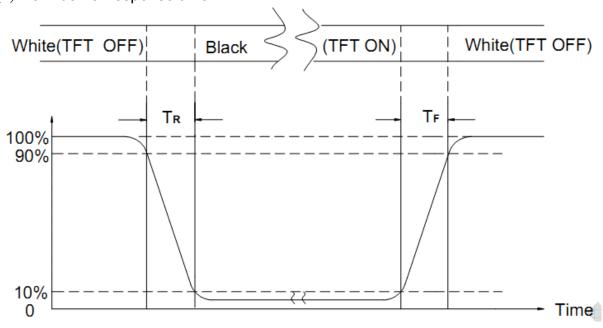


Note (3) Definition of Contrast Ratio (CR)

The contrast ratio can be calculated by the following expression Contrast Ratio (CR) = L63 / L0

L63: Luminance of gray level 63, L0: Luminance of gray level 0

Note (4) Definition of response time



Note (5) Definition of Transmittance (Module is without signal input)

Transmittance = Center Luminance of LCD / Center Luminance of Back Light x 100%

Note (6) Definition of color chromaticity (CIE1931)

Color coordinates measured at the center point of LCD



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10. Reliability Test Conditions and Methods

NO.	TEST ITEMS	TEST CONDITION	INSPECTION AFTER TEST
	High Temperature Storage	80°C±2°C×200Hours	
	Low Temperature Storage	-30°C±2°C×200Hours	
	High Temperature Operating	70°C±2°C×120Hours	Inspection after 2~4hours
	Low Temperature Operating	-20°C±2°C×120Hours	storage at room temperature, the samples should be free from
	Temperature Cycle(Storage)	-20°C $\longrightarrow$ 25°C $\longrightarrow$ 70°C (30min) (30min) 1cycle Total 10cycle	defects: 1, Air bubble in the LCD. 2, Seal leak. 3, Non-display. 4, Missing segments.
	Damp Proof Test (Storage)	50°C±5°C×90%RH×120Hours	5, Glass crack. 6, Current IDD is twice higher than initial value.
	Vibration Test	Frequency:10Hz~55Hz~10Hz Amplitude:1.5M X,Y,Z direction for total 3hours (packing condition test will be tested by a carton)	7, The surface shall be free from damage. 8, The electric characteristic requirements shall be
	Drooping Test	Drop to the ground from 1M height one time every side of carton. (packing condition test will be tested by a carton)	satisfied.
	ESD Test	Voltage:±8KV,R:330Ω,C:150PF,Air Mode,10times	

#### REMARK:

- 1, The Test samples should be applied to only one test item.
- 2, Sample side for each test item is 5~10pcs.
- 3,For Damp Proof Test, Pure water(Resistance  $> 10M\Omega$ )should be used.
- 4,In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judge as a good part.
- 5, EL evaluation should be accepted from reliability test with humidity and temperature: Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence EL has.
- 6, Failure Judgment Criterion: Basic Specification Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.



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### 11. Inspection Standard

#### 11.1. QUALITY:

THE QUALITY OF GOODS SUPPLIED TO PURCHASER SHALL COME UP TO THE FOLLOWING STANDARD.

#### 11.1.1. THE METHOD OF PRESERVING GOODS

AFTER DELIVERY OF GOODS FROM AMSON TO PURCHASER. PURCHASER SHALL CONTROL THE LCM AT -10 °C TO 40 °C ,AND IT MIGHT BE DESIRABLE TO KEEP AT THE NORMAL ROOM TEMPERATURE AND HUMIDITY UNTIL INCOMING INSPECTION OR THROWING INTO PROCESS LINE.

#### 11.1.2. INCOMING INSPECTION

#### (A) THE METHOD OF INSPECTION

IF PURCHASER MAKE AN INCOMING INSPECTION, A SAMPLING PLAN SHALL BE APPLIED ON THE CONDITION THAT QUALITY OF ONE DELIVERY SHALL BE REGARDED AS ONE LOT.

#### (B) THE STANDARD OF QUALITY

ISO-2859-1 (SAME AS MIL-STD-105E), LEVEL II SINGLE PLAN.

CLASS	AQL(%)
CRITICAL	0.4 %
MAJOR	0.65 %
MINOR	1.5 %
TOTAL	1.5 %

EVERY ITEM SHALL BE INSPECTED ACCORDING TO THE CLASS.

#### (C) MEASURE

IF AS THE RESULT OF ABOVE RECEIVING INSPECTION, A LOT OUT IS DISCOVERED. PURCHASER SHALL BE INFORM SELLER OF IT WITHIN SEVEN DAYS. BUT FIRST SHIPMENT WITHIN FOURTEEN DAYS.

#### 11.1.3. WARRANTY POLICY

AMSON WILL PROVIDE ONE-YEAR WARRANTY FOR THE PRODUCTS ONLY IF UNDER SPECIFICATION OPERATING CONDITIONS. AMSON WILL REPLACE NEW PRODUCTS FOR THESE DEFECT PRODUCTS WHICH UNDER WARRANTY PERIOD AND BELONG TO THE RESPONSIBILITY OF AMSON.

#### 11.2. CHECKING CONDITION

- 11.2.1. CHECKING DIRECTION SHALL BE IN THE 45 DEGREE AREA TO FACE THE SAMPLE.
- 11.2.2. CHECKER SHALL SEE OVER 300±25 mm. WITH BARE EYES FAR FROM SAMPLE AND USING 2 PCS. OF 20W FLUORESCENT LAMP.



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### 11.3. INSPECTION PLAN:

11.0. IIIO	TION PLAN :		
CLASS	ITEM	JUDGEMENT	CLASS
PACKING &	1. OUTSIDE AND INSIDE PACKAGE	"MODEL NO.", "LOT NO." AND "QUANTITY" SHOULD INDICATE ON THE PACKAGE.	Minor
INDICATE	2. MODEL MIXED AND QUANTITY	OTHER MODEL MIXEDREJECTED QUANTITY SHORT OR OVERREJECTED	Critical
	3. PRODUCT INDICATION	"MODEL NO." SHOULD INDICATE ON THE PRODUCT	Major
ASSEMBLY	4. DIMENSION, LCD GLASS SCRATCH AND SCRIBE DEFECT.	ACCORDING TO SPECIFICATION OR DRAWING.	Major
	5. VIEWING AREA	POLARIZER EDGE OR LCD'S SEALING LINE IS VISABLE IN THE VIEWING AREAREJECTED	Minor
	6. BLEMISH - BLACK SPOT - WHITE SPOT IN THE LCD AND LCD GLASS CRACKS	ACCORDING TO STANDARD OF VISUAL INSPECTION(INSIDE VIEWING AREA)	Minor
APPEARANCE	7. BLEMISH - BLACK SPOT WHITE SPOT AND SCRATCH ON THE POLARIZER	ACCORDING TO STANDARD OF VISUAL INSPECTION(INSIDE VIEWING AREA)	Minor
	8. BUBBLE IN POLARIZER	ACCORDING TO STANDARD OF VISUAL INSPECTION(INSIDE VIEWING AREA)	Minor
	9. LCD'S RAINBOW COLOR	STRONG DEVIATION COLOR ( OR NEWTON RING) OF LCDREJECTED.  OR ACCORDING TO LIMITED SAMPLE ( IF NEEDED, AND INSIDE VIEWING AREA )	Minor
	10. ELECTRICAL AND OPTICAL CHARACTERISTICS (CONTRAST, VOP, CHROMATICITY ETC)	ACCORDING TO SPECIFICATION OR DRAWING . (INSIDE VIEWING AREA)	Critical
ELECTRICAL	11.MISSING LINE	MISSING DOT: LINE : CHARACTERREJECTED	Critical
	12.SHORT CIRCUIT- WRONG PATTERN DISPLAY	NO DISPLAY - WRONG PATTERN  DISPLAY - CURRENT CONSUMPTION  OUT OF SPECIFICATION REJECTED	Critical
	13. DOT DEFECT (FOR COLOR AND TFT)	ACCORDING TO STANDARD OF VISUAL INSPECTION	Minor



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NO. CLASS	11.4	STANI	DARD OF VISUAL INSPECT	ΓΙΟΝ				
DIAMETER (mm.)   ACCEPTABLE QTY	NO.	CLASS	ITEM	JUDGEMENT				
BLACK AND WHITE SPOT FOREIGN MATERIEL DUST IN THE CELL BLEMISH SCRATCH  11.4.2 MINOR  BUBBLE IN POLARIZER DENT ON POLARIZER DENT ON POLARIZER  Dot Defect  Dot Defect  Dot Defect  Dot Defect  BLACK AND WHITE SPOT FOREIGN MATERIEL DUST IN THE CELL BLEMISH SCRATCH  DIAMETER ACCEPTABLE QTY				(A) ROUND TYPE: unit : mm.				
BLACK AND WHITE SPOT FOREIGN MATERIEL DUST IN THE CELL BLEMISH SCRATCH  11.4.1 MINOR  BUBBLE IN POLARIZER DENT ON POLARIZER DENT ON POLARIZER  Dot Defect  Dot D			FOREIGN MATERIEL	DIAMETER (mm.) ACCEPTABLE Q'TY				
BLACK AND WHITE SPOT FOREIGN MATERIEL DUST IN THE CELL BLEMISH SCRATCH  11.4.1 MINOR  BUBBLE IN POLARIZER DENT ON POLARIZER Dot Defect  Dot Defect  Dot Defect  Dot Defect  BLEMSH SCRATCH  BUBBLE IN POLARIZER DENT ON POLARIZER Dent on Polarizer Dot Defect  Dot Defect  Dot Defect  Dot Defect  Dot Defect  Dot Defect  BUBBLE IN POLARIZER Dot Defect  Dot D				$\Phi$ $\leq$ 0.1 DISREGARD				
Til.4.1   MINOR   FOREIGN MATERIEL DUST IN THE CELL BLEMISH SCRATCH   SC				$0.1 < \Phi \leq 0.25$ 3 (Distance>5mm)				
11.4.1 MINOR   DUST IN THE CELL   BLEMISH   SCRATCH				0.25 < Φ 0				
BLEMISH SCRATCH  (B) LINEAR TYPE: Unit: mm.  LENGTH WIDTH ACCEPTABLE QTY  W ≤ 0.03 DISREGARD  L ≤ 5.0 0.03 < W ≤ 0.07 3 (Distance>5mm)  0.07 < W FOLLOW ROUND TYPE  Unit: mm.  DIAMETER ACCEPTABLE QTY  DIAMET	11.4.1	MINOR		NOTE: Φ=(LENGTH+WIDTH)/2				
SCRATCH    LENGTH   WIDTH   ACCEPTABLE Q'TY				(B) LINEAR TYPE: unit : mm.				
L ≤ 5.0 0.03 < W ≤ 0.07 3 (Distance>5mm)  0.07 < W FOLLOW ROUND TYPE    Unit : mm.     DIAMETER   ACCEPTABLE Q'TY     DENT ON POLARIZER     DENT ON POLARIZER DENT ON POLARIZER DENT ON POLARIZER D.5 < Φ								
Unit : mm.  DIAMETER ACCEPTABLE Q'TY  DENT ON POLARIZER DENT ON POLARIZER DOT DEFECT  Dot Defect    Items   ACC. Q'TY								
unit : mm.  DIAMETER ACCEPTABLE Q'TY  DENT ON POLARIZER DENT ON POLARIZER DOT Defect    Items   ACC. Q'TY								
DIAMETER ACCEPTABLE Q'TY  □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □				0.07 < W FOLLOW ROUND TYPE				
DIAMETER ACCEPTABLE Q'TY  Φ ≤ 0.2 DISREGARD  0.2 < Φ ≤ 0.5 2 (Distance>5mm)  0.5 < Φ  Dot Defect    Diameter   Acceptable Q'TY								
BUBBLE IN POLARIZER DENT ON POLARIZER Dot Defect								
DENT ON POLARIZER   D.2 < Φ ≤ 0.5   2 (Distance>5mm)   D.5 < Φ   Dot Defect   Dark dot   N≤ 4   Dark dot   N≤ 1   Dark dot   Dark								
Dot Defect    State		MINOD						
Dot Defect    Items	11.4.2	MINOR	DENT ON POLARIZER					
Dot Defect  Bright dot N≤ 4  Dark dot N≤ 4  Pixel Define:  Pixel  Pixel  Dot → Dot				0.5 < Φ 0				
which LCD panel is displaying under pure red, green	11.4.3	MINOR	Dot Defect	Bright dot N≤ 4  Dark dot N≤ 4  Pixel Define:  Pixel  Note 1: The definition of dot: The size of a defective dot over 1/2 of whole dot is regarded as one defective dot.  Note 2: Bright dot: Dots appear bright and unchanged in size in which LCD panel is displaying under black pattern.  Note 3: Dark dot: Dots appear dark and unchanged in size in				



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NO.	CLASS	ITEM	JUDGEMEN	Т
11.4.4	MINOR	LCD GLASS CHIPPING	S S	Y > S Reject
11.4.5	MINOR	LCD GLASS CHIPPING	SXX	X or Y > S Reject
11.4.6	MAJOR	LCD GLASS GLASS CRACK	Y	Y > (1/2) T Reject
11.4.7	MAJOR	LCD GLASS SCRIBE DEFECT	A + B	1. a> L/3 , A>1.5mm. Reject  2. B: ACCORDING TO DIMENSION
11.4.8	MINOR	LCD GLASS CHIPPING ( ON THE TERMINAL AREA )	T	$\Phi$ = (x+y)/2 > 2.5 mm Reject
11.4.9	MINOR	LCD GLASS CHIPPING ( ON THE TERMINAL SURFACE )	T Z X	Y > (1/3) T Reject
11.4.10	MINOR	LCD GLASS CHIPPING	T Z	Y > T Reject



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### 12. Handling Precautions

### 12.1 Mounting method

The LCD panel of AMSON TFT module consists of two thin glass plates with polarizes which easily be damaged. And since the module in so constructed as to be fixed by utilizing fitting holes in the printed circuit board.

Extreme care should be needed when handling the LCD modules.

### 12.2 Caution of LCD handling and cleaning

When cleaning the display surface, Use soft cloth with solvent

[Recommended below] and wipe lightly

- Isopropyl alcohol
- Ethyl alcohol

Do not wipe the display surface with dry or hard materials that will damage the polarizer surface.

Do not use the following solvent:

- Water
- Aromatics

Do not wipe ITO pad area with the dry or hard materials that will damage the ITO patterns Do not use the following solvent on the pad or prevent it from being contaminated:

- Soldering flux
- Chlorine (CI), Sulfur (S)

If goods were sent without being silicon coated on the pad, ITO patterns could be damaged due to the corrosion as time goes on.

If ITO corrosion happen by miss-handling or using some materials such as Chlorine (CI), Sulfur (S) from customer, Responsibility is on customer.

### 12.3 Caution against static charge

The LCD module use C-MOS LSI drivers, so we recommended that you:

Connect any unused input terminal to POWER or GND, do not input any signals before power is turned on, and ground your body, work/assembly areas, and assembly equipment to protect against static electricity.

### 12.4 packing

- Module employs LCD elements and must be treated as such.
- Avoid intense shock and falls from a height.
- To prevent modules from degradation, do not operate or store them exposed direct to sunshine or high temperature/humidity

### 12.5 Caution for operation

- It is an indispensable condition to drive LCD's within the specified voltage limit since the higher voltage then the limit cause the shorter LCD life.
- An electrochemical reaction due to direct current causes LCD's undesirable deterioration, so that the use of direct current drive should be avoided.
- Response time will be extremely delayed at lower temperature then the operating temperature range and on the other hand at higher temperature LCD's how dark color in them. However those phenomena do not mean malfunction or out of order with LCD's, which will come back in the specified operation temperature.
- If the display area is pushed hard during operation, some font will be abnormally displayed but it resumes normal condition after turning off once.
- Slight dew depositing on terminals is a cause for electro-chemical reaction resulting in terminal open circuit.
  - Usage under the maximum operating temperature, 50%Rh or less is required.



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### 12.6 storing

In the case of storing for a long period of time for instance, for years for the purpose or replacement use, the following ways are recommended.

- Storage in a polyethylene bag with the opening sealed so as not to enter fresh air outside in it. And with no desiccant.
- Placing in a dark place where neither exposure to direct sunlight nor light's keeping the storage temperature range.
- Storing with no touch on polarizer surface by the anything else.
   [It is recommended to store them as they have been contained in the inner container at the time of delivery from us

### 12.7 Safety

- It is recommendable to crash damaged or unnecessary LCD's into pieces and wash off liquid crystal by either of solvents such as acetone and ethanol, which should be burned up later.
- When any liquid leaked out of a damaged glass cell comes in contact with your hands, please wash it off well with soap and water

#### 13. Precaution for Use

#### 13.1

A limit sample should be provided by the both parties on an occasion when the both parties agreed its necessity. Judgment by a limit sample shall take effect after the limit sample has been established and confirmed by the both parties.

#### 13.2

On the following occasions, the handing of problem should be decided through discussion and agreement between responsible of the both parties.

- When a question is arisen in this specification
- When a new problem is arisen which is not specified in this specifications
- When an inspection specifications change or operating condition change in customer is reported to AMSON TFT, and some problem is arisen in this specification due to the change
- When a new problem is arisen at the customer's operating set for sample evaluation in the customer site.

### 14. Packing Method

**TBD**